

# INTERNATIONAL STANDARD

# NORME INTERNATIONALE



INTERNATIONAL SPECIAL COMMITTEE ON RADIO INTERFERENCE  
COMITÉ INTERNATIONAL SPÉCIAL DES PERTURBATIONS RADIOÉLECTRIQUES

BASIC EMC PUBLICATION  
PUBLICATION FONDAMENTALE EN CEM

**Specification for radio disturbance and immunity measuring apparatus and methods –  
Part 2-3: Methods of measurement of disturbances and immunity – Radiated disturbance measurements**

**Spécifications des méthodes et des appareils de mesure des perturbations radioélectriques et de l'immunité aux perturbations radioélectriques –  
Partie 2-3: Méthodes de mesure des perturbations et de l'immunité –  
Mesures des perturbations rayonnées**



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Email: [inmail@iec.ch](mailto:inmail@iec.ch)  
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## CONTENTS

FOREWORD.....	7
1 Scope.....	10
2 Normative references .....	10
3 Terms and definitions .....	11
4 Types of disturbance to be measured .....	15
4.1 General.....	15
4.2 Types of disturbance .....	16
4.3 Detector functions .....	16
5 Connection of measuring equipment.....	16
6 General measurement requirements and conditions .....	17
6.1 General.....	17
6.2 Disturbance not produced by the equipment under test .....	17
6.2.1 General .....	17
6.2.2 Compliance (conformity assessment) testing .....	17
6.3 Measurement of continuous disturbance.....	17
6.3.1 Narrowband continuous disturbance.....	17
6.3.2 Broadband continuous disturbance.....	17
6.3.3 Use of spectrum analyzers and scanning receivers.....	18
6.4 Operating conditions of the EUT.....	18
6.4.1 Normal load conditions .....	18
6.4.2 The time of operation.....	18
6.4.3 Running-in time .....	18
6.4.4 Supply.....	18
6.4.5 Mode of operation.....	18
6.5 Interpretation of measuring results.....	18
6.5.1 Continuous disturbance.....	18
6.5.2 Discontinuous disturbance.....	19
6.5.3 <b>Measurement of the duration of disturbance</b> .....	19
6.6 Measurement times and scan rates for continuous disturbance .....	19
6.6.1 General.....	19
6.6.2 Minimum measurement times .....	19
6.6.3 Scan rates for scanning receivers and spectrum analyzers.....	20
6.6.4 Scan times for stepping receivers.....	21
6.6.5 Strategies for obtaining a spectrum overview using the peak detector .....	22
6.6.6 <b>Timing considerations using FFT-based instruments</b> .....	27
7 Measurement of radiated disturbances .....	30
7.1 Introductory remarks .....	30
7.2 Loop-antenna system measurements (9 kHz to 30 MHz) .....	31
7.2.1 General .....	31
7.2.2 General measurement method.....	31
7.2.3 Test environment.....	32
7.2.4 Configuration of the equipment under test .....	33
7.2.5 Measurement uncertainty for LAS.....	33
7.3 Open-area test site or semi-anechoic chamber measurements (30 MHz to 1 GHz) .....	33
7.3.1 Measurand .....	33

7.3.2	Test site requirements .....	34
7.3.3	General measurement method .....	34
7.3.4	Measurement distance.....	35
7.3.5	Antenna height variation .....	35
7.3.6	Product specification details .....	35
7.3.7	Measurement instrumentation.....	37
7.3.8	Field-strength measurements on other outdoor sites.....	37
7.3.9	Measurement uncertainty for OATS and SAC .....	37
7.4	Fully-anechoic room measurements (30 MHz to 1 GHz) .....	38
7.4.1	Test set-up and site geometry .....	38
7.4.2	EUT position.....	40
7.4.3	Cable layout and termination .....	41
7.4.4	Measurement uncertainty for FAR .....	42
7.5	Radiated emission measurement method (30 MHz to 1 GHz) and radiated immunity test method (80 MHz to 1 GHz) with common test set-up in semi-anechoic chamber .....	42
7.5.1	Applicability .....	42
7.5.2	EUT perimeter definition and antenna-to-EUT separation distance .....	42
7.5.3	Uniform test volume.....	43
7.5.4	Specifications for EUT set-up in common emissions/immunity test setup .....	44
7.5.5	Measurement uncertainty for common emission/immunity set-up and method .....	49
7.6	Fully-anechoic room and absorber-lined OATS/SAC measurements (1 GHz to 18 GHz).....	49
7.6.1	Quantity to measure .....	49
7.6.2	Measurement distance.....	49
7.6.3	Set-up and operating conditions of the equipment under test (EUT).....	49
7.6.4	Measurement site .....	50
7.6.5	Measurement instrumentation.....	50
7.6.6	Measurement procedure .....	50
7.6.7	Measurement uncertainty for FAR .....	57
7.7	<i>In situ</i> measurements (9 kHz to 18 GHz) .....	57
7.7.1	Applicability of and preparation for <i>in situ</i> measurements .....	57
7.7.2	Field-strength measurements <i>in situ</i> in the frequency range 9 kHz to 30 MHz.....	58
7.7.3	Field-strength measurements <i>in situ</i> in the frequency range above 30 MHz.....	59
7.7.4	<i>In situ</i> measurement of the disturbance effective radiated power using the substitution method .....	60
7.7.5	Documentation of the measurement results .....	64
7.7.6	Measurement uncertainty for <i>in situ</i> method .....	64
7.8	Substitution measurements (30 MHz to 18 GHz) .....	64
7.8.1	General .....	64
7.8.2	Test site .....	64
7.8.3	Test antennas.....	65
7.8.4	EUT configuration.....	65
7.8.5	Test procedure .....	65
7.8.6	Measurement uncertainty for substitution method .....	66

7.9	Reverberation chamber measurements (80 MHz to 18 GHz).....	66
7.10	TEM waveguide measurements (30 MHz to 18 GHz).....	66
8	Automated measurement of emissions .....	66
8.1	Introduction – precautions for automated measurements .....	66
8.2	Generic measurement procedure.....	67
8.3	Pre-scan measurements.....	67
8.3.1	General .....	67
8.3.2	Determination of the required measurement time.....	67
8.3.3	Pre-scan requirements for different types of measurements .....	68
8.4	Data reduction.....	69
8.5	Emission maximization and final measurement.....	70
8.6	Post-processing and reporting.....	71
8.7	<b>Emission measurement strategies with FFT-based measuring instruments.....</b>	<b>71</b>
Annex A (informative)	Measurement of disturbances in the presence of ambient emissions .....	72
Annex B (informative)	Use of spectrum analyzers and scanning receivers .....	86
Annex C (informative)	Scan rates and measurement times for use with the average detector .....	89
Annex D (informative)	Explanation of APD measurement method applying to the compliance test.....	93
Annex E (normative)	Determination of suitability of spectrum analyzers for compliance tests .....	95
Bibliography.....		96
Figure 1 – Measurement of a combination of a CW signal (NB) and an impulsive signal (BB) using multiple sweeps with maximum hold .....		23
Figure 2 – Example of a timing analysis.....		24
Figure 3 – A broadband spectrum measured with a stepped receiver.....		25
Figure 4 – Intermittent narrowband disturbances measured using fast short repetitive sweeps with maximum hold function to obtain an overview of the emission spectrum.....		26
Figure 5 – Concept of magnetic field induced current measurements made with the loop antenna system.....		32
Figure 6 – Concept of electric field strength measurements made on an open-area test site (OATS) or semi-anechoic chamber (SAC) showing the direct and reflected rays arriving at the receiving antenna .....		34
Figure 7 – Typical FAR site geometry, where $a, b, c, e$ depend upon the room performance .....		38
Figure 8 – Typical test set-up for table-top equipment within the test volume of a FAR .....		39
Figure 9 – Typical test set-up for floor-standing equipment within the test volume of a FAR.....		40
Figure 10 – Positions of reference planes for uniform field calibration (top-view) .....		43
Figure 11 – Test set-up for table-top equipment.....		47
Figure 12 – Test set-up for table-top equipment – Top view .....		47
Figure 13 – Test set-up for floor-standing equipment .....		48
Figure 14 – Test set-up for floor-standing equipment – Top view .....		48

Figure 15 – Measurement method above 1 GHz, receive antenna in vertical polarization.....	51
Figure 16 – Illustration of height scan requirements for two different categories of EUTs .....	53
Figure 17 – Determination of the transition distance .....	63
Figure 18 – Substitution method set-up geometries for: a) measurement, b) calibration .....	65
Figure 19 – Process to give reduction of measurement time .....	67
<b>Figure 20 – FFT scan in segments .....</b>	<b>28</b>
<b>Figure 21 – Frequency resolution enhanced by FFT-based measuring instrument.....</b>	<b>29</b>
Figure A.1 – Flow diagram for the selection of bandwidths and detectors and the estimated measurement errors due to that selection .....	74
Figure A.2 – Relative difference in adjacent emission amplitudes during preliminary testing .....	76
Figure A.3 – Disturbance by an unmodulated signal (dotted line).....	77
Figure A.4 – Disturbance by an amplitude-modulated signal (dotted line).....	77
Figure A.5 – Indication of an amplitude-modulated signal as a function of modulation frequency with the QP detector in CISPR bands B, C and D.....	78
Figure A.6 – Indication of a pulse-modulated signal (pulse width 50 $\mu$ s) as a function of pulse repetition frequency with peak, QP and average detectors.....	79
Figure A.7 – Disturbance by a broadband signal (dotted line).....	79
Figure A.8 – Unmodulated EUT disturbance (dotted line).....	80
Figure A.9 – Amplitude-modulated EUT disturbance (dotted line).....	81
Figure A.10 – Increase of peak value with superposition of two unmodulated signals.....	82
Figure A.11 – Determination of the amplitude of the disturbance signal by means of the amplitude ratio $d$ and the factor $i$ [see Equation (A.3) and Equation (A.6)].....	83
Figure A.12 – Increase of average indication measured with a real receiver and calculated from Equation (A.8).....	84
Figure C.1 – Weighting function of a 10 ms pulse for peak (PK) and average detections with (CISPR AV) and without (AV) peak reading: meter time constant 160 ms .....	91
Figure C.2 – Weighting functions of a 10 ms pulse for peak (PK) and average detections with (CISPR AV) and without (AV) peak reading: meter time constant 100 ms.....	91
Figure C.3 – Example of weighting functions (of a 1 Hz pulse) for peak (PK) and average detections as a function of pulse width: meter time constant 160 ms .....	92
Figure C.4 – Example of weighting functions (of a 1 Hz pulse) for peak (PK) and average detections as a function of pulse width: meter time constant 100 ms .....	92
Figure D.1 – Example of APD measurement Method 1 for fluctuating disturbances.....	93
Figure D.2 – Example of APD measurement Method 2 for fluctuating disturbances.....	94
Table 1 – Minimum scan times for the three CISPR bands with peak and quasi-peak detectors .....	20
Table 2 – Applicable frequency ranges and document references for CISPR radiated emission test sites and test methods.....	30
Table 3 – Minimum dimension of $w$ ( $w_{\min}$ ).....	52
Table 4 – Example values of $w$ for three antenna types.....	53
Table 5 – Horizontal polarization correction factors as a function of frequency.....	62
Table 6 – Recommended antenna heights to guarantee signal interception (for pre-scan) in the frequency range 30 MHz to 1 000 MHz .....	69

<b>Table 7 – Minimum measurement times for the four CISPR bands</b> .....	20
Table A.1 – Combinations of EUT disturbance and ambient emissions.....	73
Table A.2 – Measurement error depending on the detector type and on the combination of ambient and disturbing signal spectra .....	85
Table C.1 – Pulse suppression factors and scan rates for a 100 Hz video bandwidth .....	90
Table C.2 – Meter time constants and the corresponding video bandwidths and maximum scan rates .....	90
Table E.1 – Maximum amplitude difference between peak and quasi-peak detected signals .....	95

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INTERNATIONAL ELECTROTECHNICAL COMMISSION  
INTERNATIONAL SPECIAL COMMITTEE ON RADIO INTERFERENCE

**SPECIFICATION FOR RADIO DISTURBANCE AND IMMUNITY  
MEASURING APPARATUS AND METHODS –**

**Part 2-3: Methods of measurement of disturbances and immunity –  
Radiated disturbance measurements**

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